IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned Examiner: To Be Assigned

STATEMENT

In re PATENT APPLICATION of

Applicant(s) : Masaru TAKAISHI et al.

Appln. No. : To Be Assigned

Filed : December 31, 2003) INFORMATION) DISCLOSURE

For : SEMICONDUCTOR DEVICE

Atty. Dkt. : AI 321

Commissioner for Patents Washington, D.C. 20231

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b) (1).

Attached is a copy of one Japanese patent publication. Any relevance of Japanese publication can be gleaned from the attached English-language Abstract, and its discussion on page 1 of the specification. The document is listed on the attached Form PTO-1449.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the document submitted. Consideration of the submitted document is respectfully requested.

Respectfully submitted,

December 31, 2003

Date

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT				Atty Docket Al 321		Application No. To Be Assigned			
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